

BF7264 Series SD 3.0 / SD 4.0 / SDIO 3.0 analyzer



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Feature

Supported Models:

| BF6264B | BF7264B | BF7264B+ | BF7264 Pro |
|---------|---------|----------|------------|
| • | • | • | • |

BF7264B/B+/Pro has two USB holes at the front.

BF7264B/B+/Pro, 32Gb RAM

1. With SD 4.0 / SD 3.0 probe, SD3.0 signal can be measured.

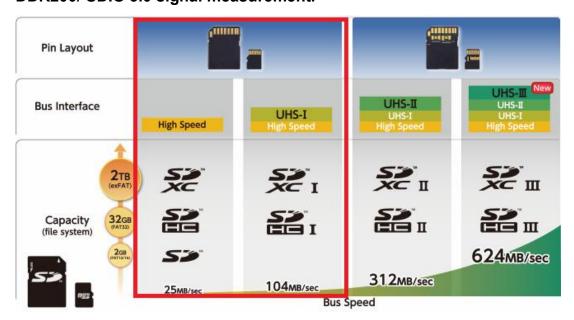


2. With SD 4.0 probe, SD4.0 signal can be measured.

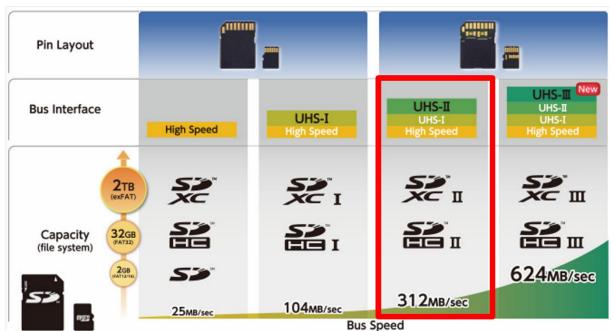




SD 3.0 solution supports SD 3.0 SDR104 / SD6.0 Legacy mode SDR104, DDR200/ SDIO 3.0 signal measurement.



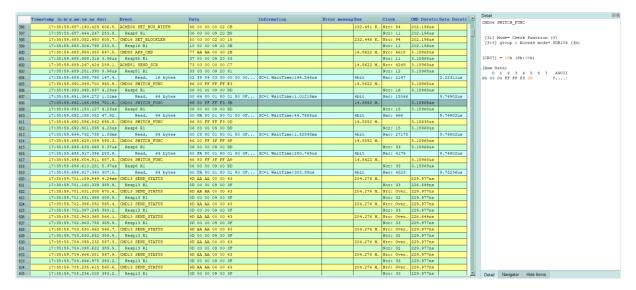
SD4.0 solution supports SD 4.0 signal measurement.



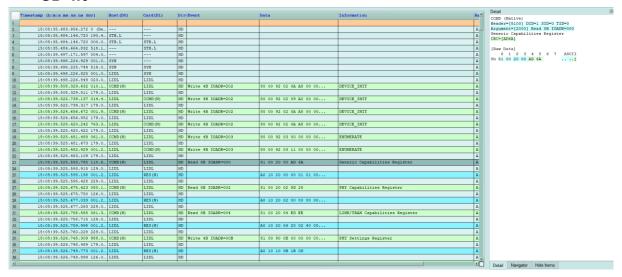


 Can display SD 3.0 / SD 4.0 protocol packet data in tabular form, including command parsing

SD 3.0

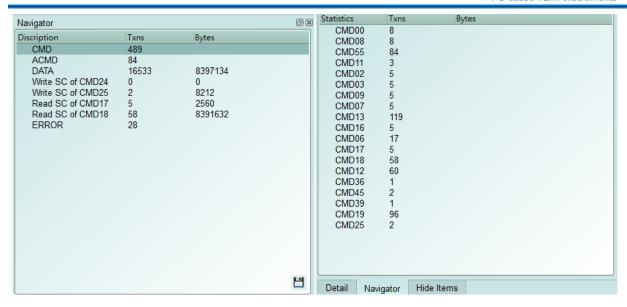


SD 4.0



- II. Use 32Gb RAM as the buffer to stream all SD 3.0 / SD 4.0 data into the SSD HD in order to record all data flow from Low Power Mode to High Speed Mode.
- III. "Data Filter" filters unwanted data to save memory.
- IV. "Search" searches specific data.
- V. "CRC Packet" displays and counts CRC
- VI. SD 3.0 / SD 4.0 command statistics include numbers of packets, individual command, different data length, and errors
 SD 3.0





SD 4.0

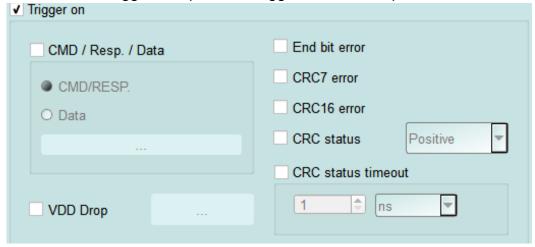
| Description | Txns | Bytes |
|---|------|-------|
| UHSII Bus | | |
| Command Count | 34 | |
| ▼ Read/Write Count | 11 | |
| Read Count | 11 | |
| Write Count | 0 | |
| Write SC of CMD24 | 0 | 0 |
| Write SC of CMD25 | 0 | 0 |
| Read SC of CMD17 | 0 | 0 |
| Read SC of CMD18 | 0 | 0 |
| ERROR | 0 | 0 |
| Others | 0 | 0 |
| | | |
| Rd Data(TLen= 1) | 5 | |
| Rd Data(TLen= 2) | 1 | |
| Rd Data(TLen= 1) Rd Data(TLen= 2) Rd Data(TLen= 16) | | |
| Rd Data(TLen= 1) Rd Data(TLen= 2) | 1 4 | |
| Rd Data(TLen= 1) Rd Data(TLen= 2) Rd Data(TLen= 16) | 1 4 | |
| Rd Data(TLen= 1) Rd Data(TLen= 2) Rd Data(TLen= 16) | 1 4 | |
| Rd Data(TLen= 1) Rd Data(TLen= 2) Rd Data(TLen= 16) | 1 4 | |
| Rd Data(TLen= 1) Rd Data(TLen= 2) Rd Data(TLen= 16) | 1 4 | |
| Rd Data(TLen= 1) Rd Data(TLen= 2) Rd Data(TLen= 16) | 1 4 | |
| Rd Data(TLen= 1) Rd Data(TLen= 2) Rd Data(TLen= 16) | 1 4 | |
| Rd Data(TLen= 1) Rd Data(TLen= 2) Rd Data(TLen= 16) | 1 4 | |

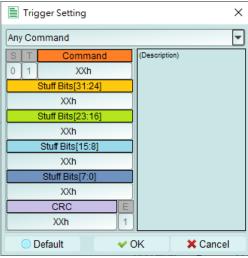
VII. SD 3.0 command trigger

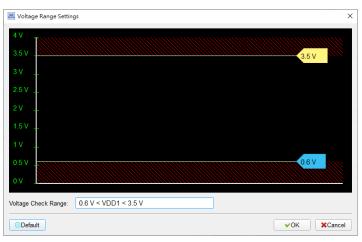
1. SD 3.0



- a. Trigger parameters include commands and data in order to cover all kinds of packets.
- **b.** Command or 16 byte Data.
- c. CRC7, CRC16, End Bit Error.
- d. CRC Status timeout, CRC Status pattern.
- e. VCC drop, VCCQ2 drop.
- **f.** The Trigger-Out port is to trigger a DSO to capture waveforms



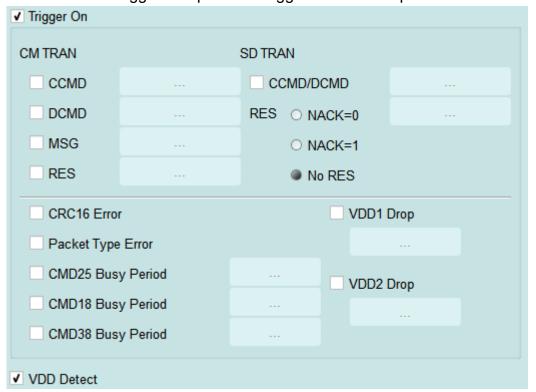






2. SD 4.0

- a. Trigger parameters include commands and data in order to cover all kinds of packets.
- **b.** Command, Message, Response
- c. CRC16, Packet Type Error.
- d. VDD1 drop, VDD2 drop.
- e. The Trigger-Out port is to trigger a DSO to capture waveforms





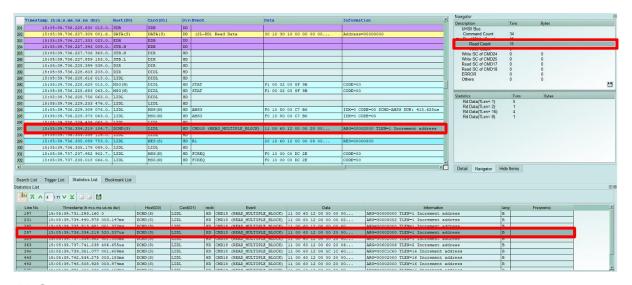
VIII. Report area

Statistics list: Quickly categorize and track the location of data with statistical functions

SD 3.0



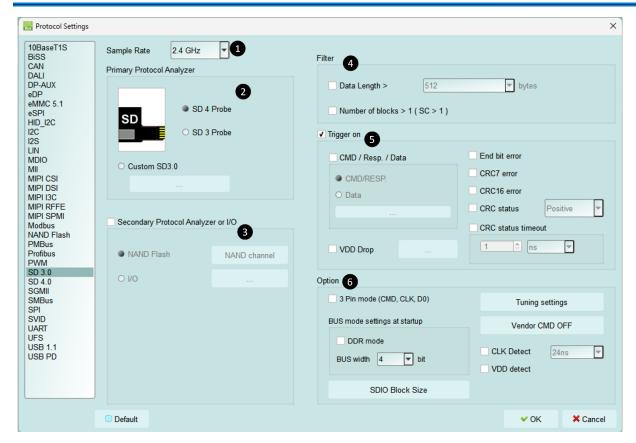
SD 4.0



IX. Settings

SD 3.0



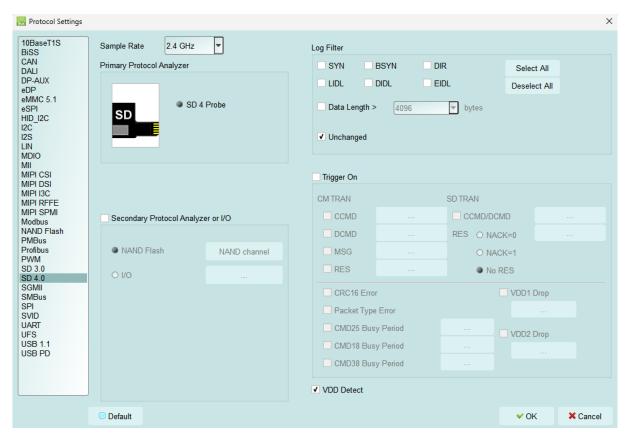


- Sample Rate: Choose the sampling rate to use. To enable the Secondary Protocol Analyzer – NAND Flash option, the sampling rate must be set below 1GHz,
- 2. Primary Protocol Analyzer: Choose to use the probe type, and set the channel / trigger level,
- 3. Secondary Protocol Analyzer or I/O: An additional set of specified logic analysis can be opened to analyze the remaining available pins at the same time,
- **4. Filter:** Each Data Frame can specify the size of the collection, and data larger than the set value will not be recorded
- **5. Trigger on:** CMD, DATA, ERROR, Voltage, Timeout, CRC Status trigger conditions can be set
- 6. Option:
 - **a. 3 Pin mode:** After connecting CLK, CMD, D0, the protocol flow and status agreement can be analyzed,
 - **b. Startup:** It needs to be set to the mode of the current acquisition, the mode of the test object is running, and has the Tuning function.
 - c. Tuning setting: Adjust channel phase.



- **d. Vendor CMD:** Can change the name of the command group by itself, with or without data,
- e. CLK Detect: Can detect whether CLK has action,
- f. Two sets of voltage detection function

SD 4.0





FAQ

1. What SD version is supported?

A: Support SD3.0 SDR104, SD6.0 Legacy mode SDR104 / DDR200, SD 4.0

2. Will the signal quality be affected during measurement?

A: The measurement of the external instrument will inevitably have some load effect. We use the active probe to reduce the interference of the object to be measured and improve the signal quality.

3. Is Tx supported?

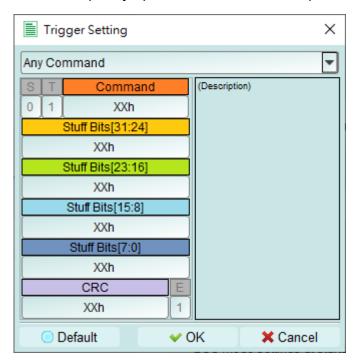
A: No

4. Precautions during measurement

Please make sure to connection according to the "Probe and test object connection" on page 9.

5. Can I specify an SD 3.0 / SD 4.0 packet as the trigger point function?

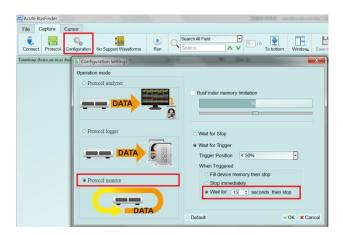
A: You can specify specific SD 3.0 / SD 4.0 packet or Error to trigger.





6. Is it possible to set an SD 3.0 / SD 4.0 starting point, and specify how much time to capture Data?

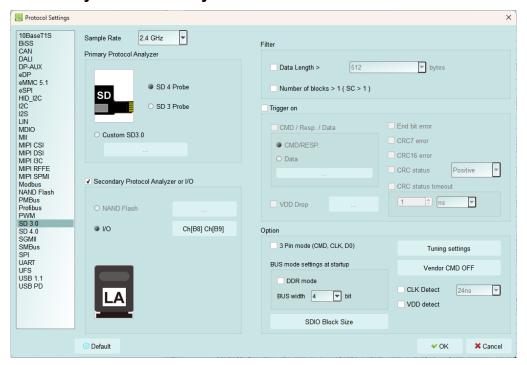
A: You can set the starting condition to the trigger item and adjust to the data monitor mode in the working mode menu. And specify the length of acquisition time.





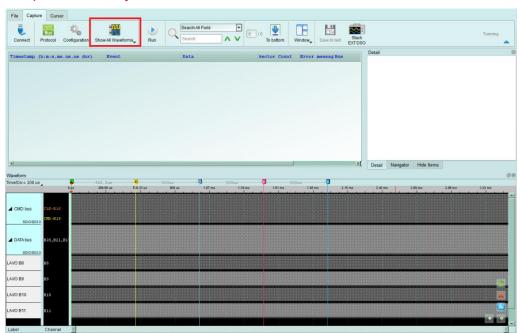


7. Secondary Protocol Analyzer or I/O



While using the SD3.0 protocol analyzer, you can additionally enable the NAND Flash logic analyzer function or additional I/O pins for analysis.

To use this function, you must turn on the "Show Waveform" on the main screen of the protocol analyzer.



Since the analysis of NAND Flash requires the use of more channels, an LA probe needs to be connected to Slot A, and it can only be turned on using a sampling rate of 1GHz.

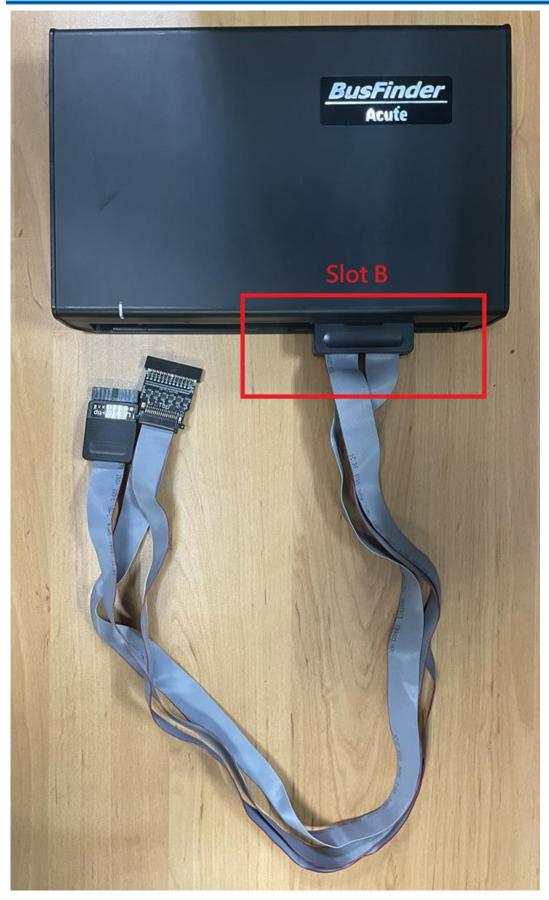


BusFinder and Probe connection

The BusFinder can only use Slot B as the probe connection slot.









Probe and test object connection

SD 3.0







SD 4.0



SD 4.0 has an additional high-speed cable than SD 3.0, which must be connected to the cable when using it.

SD4.0 adapter board test point:

When to use:

- a. When you need to use the oscilloscope to view the waveform at the same time
- b. When the flexible circuit of the transfer board can be checked whether it is normal, the electric meter can measure whether the golden finger of the front end is connected to the measuring point.



